

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination MCCARTNEY ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Kyung H Shin	2143	

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	C	US-6,345,256	02-2002	Milsted et al.	705/1
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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